

<b>Notice of References Cited</b>	Application/Control No. 10/533,375		Applicant(s)/Patent Under Reexamination MENDELS, DAVID A.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,047,000 A	09-1977	Bryant et al.	700/225
*	B	US-5,059,245 A	10-1991	Phillips et al.	106/31.65
*	C	US-5,118,369 A	06-1992	Shamir, Harry A.	156/64
*	D	US-5,175,425 A	12-1992	Spratte et al.	235/494
*	E	US-5,298,731 A	03-1994	Ett, Allen H.	235/462.02
*	F	US-5,478,616 A	12-1995	Kochem et al.	428/35.2
*	G	US-5,712,731 A	01-1998	Drinkwater et al.	359/619
*	H	US-5,907,144 A	05-1999	Poon et al.	235/462.08
*	I	US-6,083,806 A	07-2000	Mancini et al.	438/401
*	J	US-6,220,333 B1	04-2001	Cantwell, Jay S.	164/4.1
*	K	US-2001/0055422 A1	12-2001	ROUSTAEI, ALEXANDER R.	382/181
*	L	US-2002/0070281 A1	06-2002	Nimura et al.	235/494
*	M	US-6,420,792 B1	07-2002	Guldi et al.	257/797

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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	U	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0104762 A1	08-2002	Stonas et al.	205/118
*	B	US-2002/0166896 A1	11-2002	Mazumder, Jyoti	235/487
*	C	US-2002/0192572 A1	12-2002	Lau, Simon	430/5
*	D	US-2003/0047816 A1	03-2003	Dutta, Partha	257/788
*	E	US-2003/0080189 A1	05-2003	Patel et al.	235/454
*	F	US-2003/0145747 A1	08-2003	Mayer et al.	101/395
*	G	US-2003/0203314 A1	10-2003	Sebald et al.	430/296
*	H	US-6,649,249 B1	11-2003	Engle et al.	428/195.1
*	I	US-6,666,255 B2	12-2003	Cantwell, Jay S.	164/98
*	J	US-2003/0234286 A1	12-2003	Labrec et al.	235/380
*	K	US-2004/0038310 A1	02-2004	Bawendi et al.	435/7.1
*	L	US-2004/0058328 A1	03-2004	Chan et al.	435/006
*	M	US-2004/0081799 A1	04-2004	Kaminsky et al.	428/141

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
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#### NON-PATENT DOCUMENTS

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0126820 A1	07-2004	Chan et al.	435/007.4
*	B	US-2004/0155113 A1	08-2004	Urano et al.	235/491
*	C	US-2004/0178076 A1	09-2004	Stonas et al.	205/074
*	D	US-2004/0245343 A1	12-2004	Depta, Georg	235/491
*	E	US-2004/0249764 A1	12-2004	Delitz et al.	705/060
*	F	US-2005/0138996 A1	06-2005	Berlin et al.	073/105
*	G	US-2005/0208554 A1	09-2005	Chan et al.	435/006
*	H	US-2006/0131417 A1	06-2006	Kucher et al.	235/462.01
*	I	US-2006/0131425 A1	06-2006	Stenzel et al.	235/491
*	J	US-2006/0196945 A1	09-2006	Mendels, David A.	235/470
*	K	US-2006/0198950 A1	09-2006	Lee, Byung-kyu	427/130
*	L	US-2006/0268412 A1	11-2006	Downing et al.	359/569
*	M	US-2006/0269851 A1	11-2006	Frisa et al.	430/005

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,185,816 B1	03-2007	Shoobridge, Richard Allen	235/462.04
*	B	US-7,252,235 B2	08-2007	Kucher et al.	235/462.16
*	C	US-7,267,280 B2	09-2007	Lubow, Allen	235/462.01
*	D	US-2007/0275205 A1	11-2007	Ootera et al.	428/64.4
*	E	US-2007/0278192 A1	12-2007	Blakeley, Philip John	219/121.6
*	F	US-2008/0092377 A1	04-2008	HEITZINGER, John M.	29/846
*	G	US-7,476,786 B2	01-2009	Chan et al.	435/6
*	H	US-2009/0087912 A1	04-2009	Ramos et al.	436/27
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	X	

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